

CED11P20

-200V ▲ 300mΩ ▲ -10.5A ▲ Si MOSFET

SILICON Si MOSFET ▲ THT type

P-channel enhancement mode

UL94V-0 rated flame retardant epoxy

TO251 (E-PAK) package

Super high dense cell density for extremely low $R_{DS(ON)}$

High power and current handling capability

MAXIMUM RATINGS

Parameter ($T_C = 25^\circ\text{C}$, unless otherwise noted)		Characteristics
Drain-Source Voltage	V_{DS}	-200V
Gate-Source Voltage	V_{GS}	$\pm 30\text{V}$
Continuous Drain Current	I_D	-10.5A
Pulsed Drain Current ^{Note 1}	I_{DM}	-42A
Maximum Power Dissipation at $T_C = 25^\circ\text{C}$	P_D	78W
Power Dissipation Derating above 25°C	ΔP_D	$0.6\text{W}/^\circ\text{C}$
Single Pulsed Avalanche Energy ^{Note 5}	E_{AS}	165mJ
Single Pulsed Avalanche Current ^{Note 5}	I_{AS}	10.5A
Operating and Storage Temperature Range	T_J, T_{STG}	-55°C to $+150^\circ\text{C}$

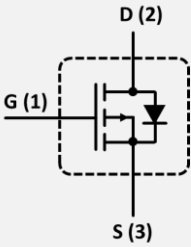
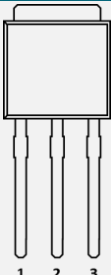
THERMAL CHARACTERISTICS

Parameter	Symbol	Limit
Thermal Resistance, Junction-to-Case	R_{TH_JC}	$1.6^\circ\text{C}/\text{W}$
Thermal Resistance, Junction-to-Ambient ^{Note 2}	R_{TH_JA}	$50^\circ\text{C}/\text{W}$

APPLICATIONS

CCTV	Large Displays	Pico Cells	Power over Ethernet	WIFI Hotspots
				

PIN DESCRIPTION

Circuit Diagram	Outline - Front View	Pin No.	Description
		1 2 3	Gate Drain Source

ELECTRICAL CHARACTERISTICS ▲ $T_C = 25^\circ\text{C}$, unless otherwise noted

Item	Condition	Symbol	Min.	Typ.	Max.	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = -250\mu A$	BV_{DSS}	-200			V
Zero Gate Voltage Drain Current	$V_{DS} = -200V, V_{GS} = 0V$	I_{DSS}			-1	μA
Gate Body Leakage Current, Forward	$V_{GS} = 30V, V_{DS} = 0V$	I_{GSSF}			100	nA
Gate Body Leakage Current, Reverse	$V_{GS} = -30V, V_{DS} = 0V$	I_{GSSR}			-100	nA
On Characteristics <small>Note 4</small>						
Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = -250\mu A$	$V_{GS(th)}$	-2		-4	V
Static Drain-Source On-Resistance	$V_{GS} = -10V, I_D = -5.2A$	$R_{DS(ON)}$		300	360	m Ω
Dynamic Characteristics <small>Note 4</small>						
Input Capacitance	$V_{DS} = -25V, V_{GS} = 0V, f = 1MHz$	C_{ISS}		1620		pF
Output Capacitance	$V_{DS} = -25V, V_{GS} = 0V, f = 1MHz$	C_{OSS}		240		pF
Reverse Transfer Capacitance	$V_{DS} = -25V, V_{GS} = 0V, f = 1MHz$	C_{RSS}		50		pF
Switching Characteristics <small>Note 4</small>						
Turn-On Delay Time	$V_{DD} = -100V, V_{GS} = -10V, I_D = -13.5A, R_{G(ext)} = 25\Omega$	$t_{D(ON)}$		28		ns
Turn-On Rise Time	$V_{DD} = -100V, V_{GS} = -10V, I_D = -13.5A, R_{G(ext)} = 25\Omega$	t_R		74		ns
Turn-Off Delay Time	$V_{DD} = -100V, V_{GS} = -10V, I_D = -13.5A, R_{G(ext)} = 25\Omega$	$t_{D(OFF)}$		260		ns
Turn-Off Fall Time	$V_{DD} = -100V, V_{GS} = -10V, I_D = -13.5A, R_{G(ext)} = 25\Omega$	t_F		120		ns
Total Gate Charge	$V_{DS} = -160V, V_{GS} = -10V, I_D = -13.5A$	Q_G		52		nC
Gate Source Charge	$V_{DS} = -160V, V_{GS} = -10V, I_D = -13.5A$	Q_{GS}		9		nC
Gate Drain Charge	$V_{DS} = -160V, V_{GS} = -10V, I_D = -13.5A$	Q_{GD}		25		nC
Drain-Source Diode Characteristics and Maximum Ratings						
Drain-Source Diode Forward Current <small>Note 2</small>		I_S			-10.5	A
Drain-Source Diode Forward Voltage <small>Note 3</small>	$V_{GS} = 0V, I_S = -10.5A$	V_{SD}			-1.2	V

Notes

- 1: Repetitive Rating: Pulse width limited by maximum junction temperature
- 2: Surface Mounted on FR4 Board, $t \leq 10\text{sec}$.
- 3: Pulse Test: Pulse Width $\leq 300\mu s$, Duty Cycle $\leq 2\%$.
- 4: Guaranteed by design, not subject to production testing.
- 5: $L = 3mH, I_{AS} = 10.5A, V_{DD} = 25V, R_G = 25\Omega$, Starting $T_J = 25^\circ\text{C}$

REFERENCE DATA ▲ TYPICAL DEVICE PERFORMANCE

Fig. 1 • Output Characteristics

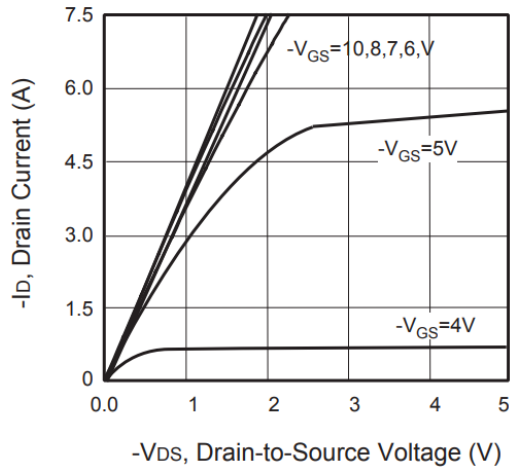


Fig. 2 • Transfer Characteristics

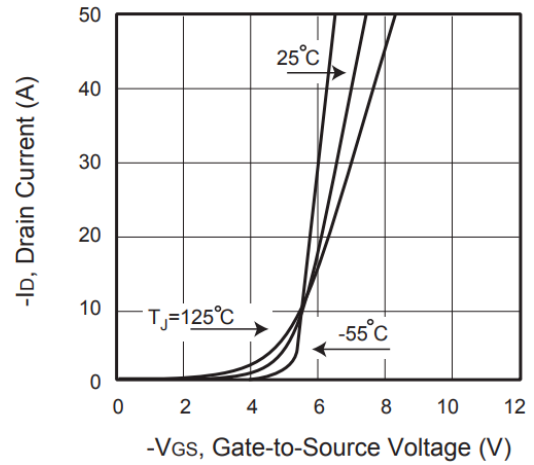


Fig. 3 • Capacitance

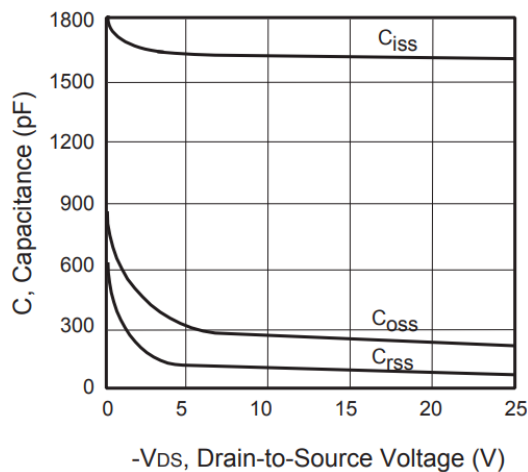


Fig. 4 • On-Resistance Variation with Temperature

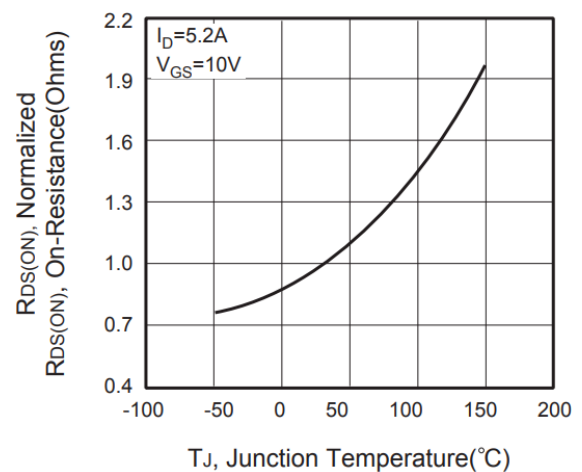


Fig. 5 • Gate Threshold Variation with Temperature

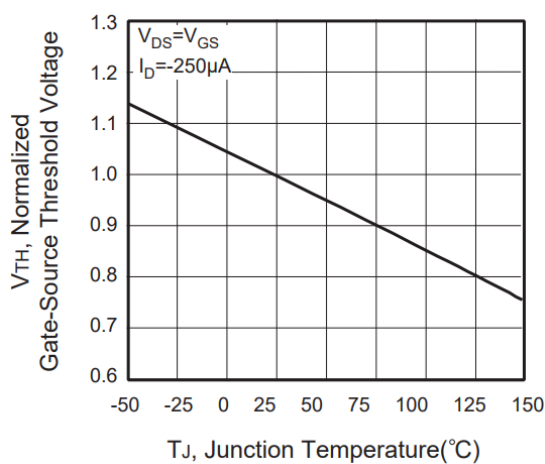
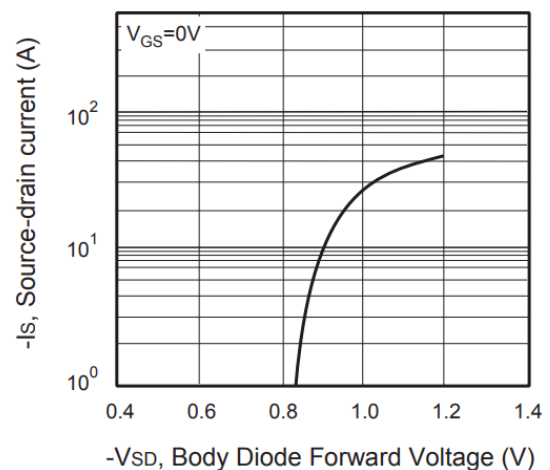


Fig. 6 • Body Diode Forward Voltage Variation with Source Current



REFERENCE DATA ▲ TYPICAL DEVICE PERFORMANCE

Fig. 7 • Gate Charge

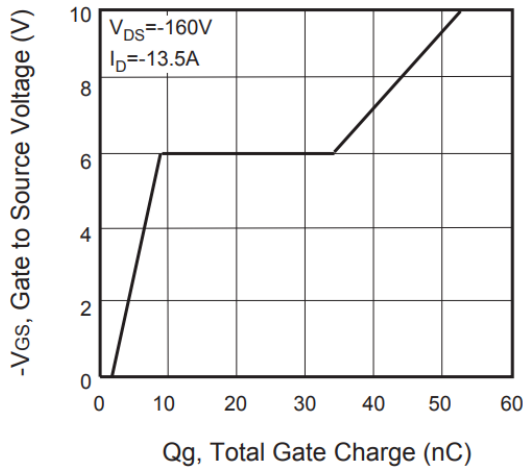


Fig. 8 • Maximum Safe Operating Area

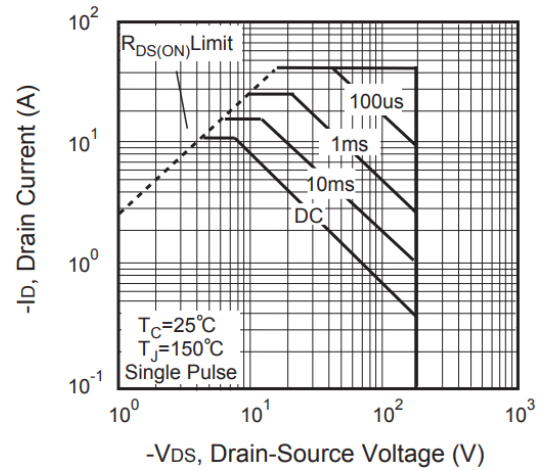


Fig. 9 • Switching Test Circuit

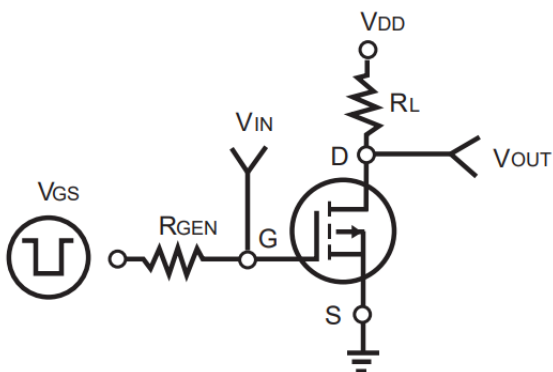


Fig. 10 • Switching Waveforms

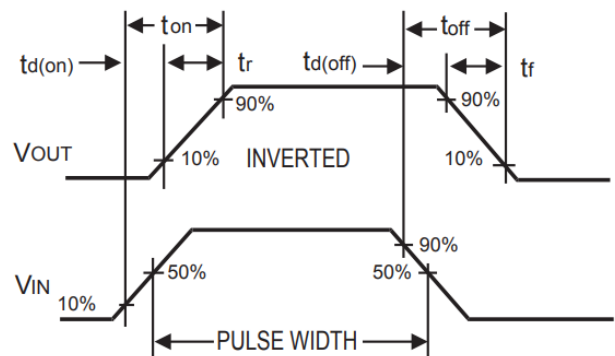
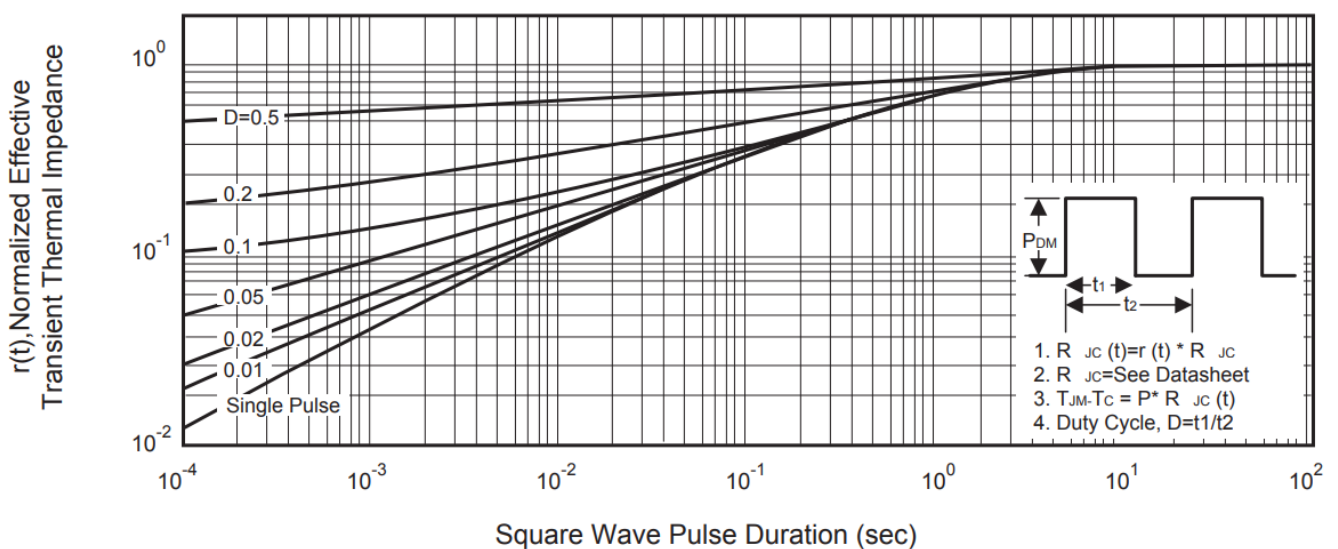
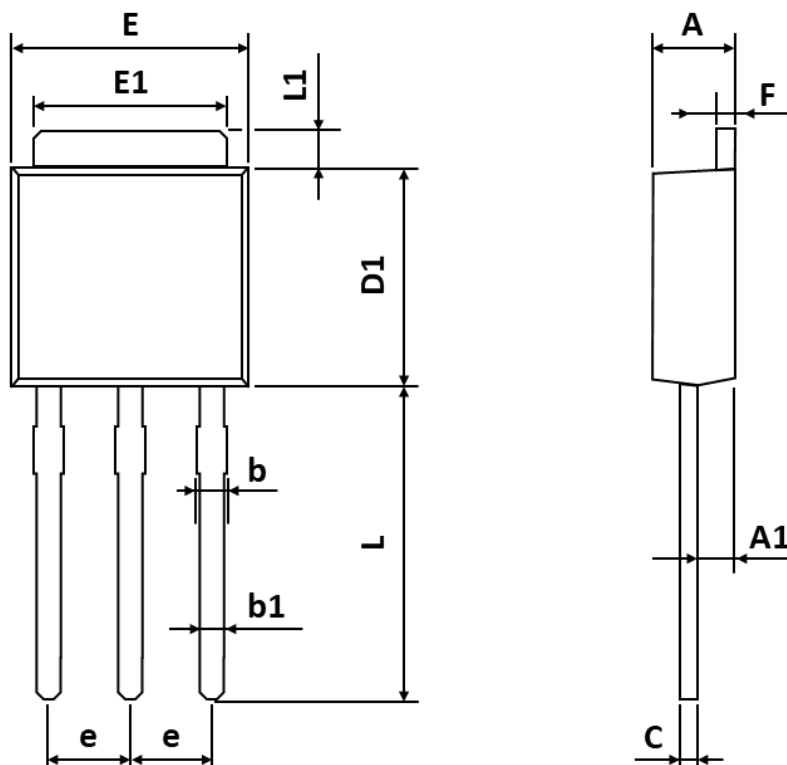


Fig. 11 • Normalized Thermal Transient Impedance Curve



PACKAGE OUTLINE

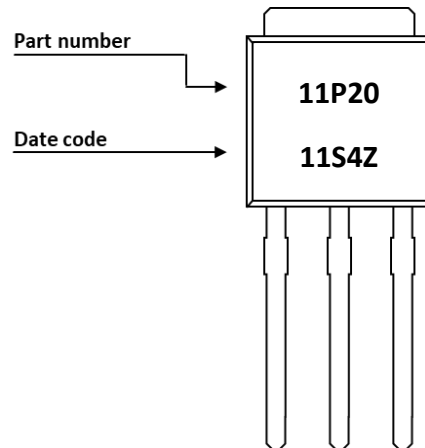


Sym	Millimeters (Min.)	Millimeters (Typ.)	Millimeters (Max.)
A	2.180	-	2.400
A1	0.860	-	1.500
b	0.700	-	0.960
b1	0.700	-	0.860
C	0.400	-	0.610
D1	5.400	-	6.630
E	6.050	-	7.010
E1	4.950	-	5.460
e	1.980	-	2.590
F	0.400	-	0.890
L	8.500	-	9.650
L1	0.500	-	1.800

ORDERING INFORMATION

Part Number	Package	Packing	Tube Qty.	Inner Box Qty.	Outer Box Qty.
CED11P20	TO251 (E-PAK)	Tube	80pcs	4,000pcs	16,000pcs

PART MARKING



DATE CODE

Example: 11S4Z



Coding list for „Day“

1	2	3	4	5	6	7	8	9	A
01	02	03	04	05	06	07	08	09	10
B	C	D	E	F	G	H	I	J	K
11	12	13	14	15	16	17	18	19	20
L	M	N	O	P	Q	R	S	T	U
21	22	23	24	25	26	27	28	29	30
V									
31									

Coding list for „Month“

1	2	3	4	5	6
Jan	Feb	Mar	Apr	May	Jun
7	8	9	A	B	C
Jul	Aug	Sep	Oct	Nov	Dec

Coding list for „Year“

0	1	2	3	4
2020	2021	2022	2023	2024
5	6	7	8	9
2025	2026	2027	2028	2029

RECOMMENDED WAVE SOLDERING PROFILE ▲ THT PACKAGE



Classification wave soldering profile ▲ Refer to EN 61760-1: 2006

Profile Features		Value ▲ Sn-Pb Assembly	Value ▲ Pb-free Assembly
Preheat temperature min.	$T_{s \min}$	100 °C	100 °C
Preheat temperature typical	$T_{s \text{ typ}}$	120 °C	120 °C
Preheat temperature max.	$T_{s \max}$	130 °C	130 °C
Preheat time t_s from $T_{s \min}$ to $T_{s \max}$	t_s	70 seconds	70 seconds
Peak temperature	T_p	235 °C to 260 °C	245 °C to 260 °C
Time of actual peak temperature	t_p	Max. 10 seconds Max. 5 second each wave	Max. 10 seconds Max. 5 second each wave
Ramp-down rate min.		~ 2 °C/second	~ 2 °C/second
Ramp-down rate typical		~ 3.5 °C/second	~ 3.5 °C/second
Ramp-down rate max.		~ 5 °C/second	~ 5 °C/second
Time 25°C to 25°C		4 minutes	4 minutes

REVISION TABLE

Revision	Date	Status	Notes
001	30/09/2022	Initial release	Initial publication

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